

Chirped Phase Mask Interferometer for Fiber Bragg Grating Array Inscription

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Abstract—We present a phase mask inscription technique with two beam interferometry using a lateral nonhomogeneous beam splitter to create gratings with nonhomogeneous periods, the so-called chirped fiber Bragg gratings. Inscription experiments with deep ultraviolet excimer and femtosecond laser sources reveal how this inscription method depends on the coherence properties of the inscription laser. Nonhomogeneous beam splitters are shown to provide a method to generate chirped fiber Bragg gratings with great wavelength versatility, even with the ultraviolet femtosecond laser.

Index Terms—Femtosecond laser, fiber Bragg gratings, optical fiber filters, two-beam interferometry.

I. INTRODUCTION

CONTINUOUSLY chirped fiber Bragg gratings (C-CFBG) are key components for dispersion compensation [1] and light source tailoring [2], [3], and are used as broad reflection bandwidth laser mirrors [4]. When dispersion properties do not matter, broad bandwidth reflection gratings can also be achieved with homogeneous index modulation profiles. In this case, the bandwidth is given by the superposition of the number of grating fringes and the applied refractive index increase [5]. For strong gratings, where the refractive index modulation increase Δn exceeds the inverse number of grating fringes N ($\Delta n/(2n_{\text{eff}}) \gg 1/N$), the approximate full-width-half-maximum (FWHM) reflection bandwidth $\Delta\lambda_{\text{Bragg}}$ can be described as

$$\Delta\lambda_{\text{Bragg}} \approx \lambda_{\text{Bragg}} \frac{\Delta n}{2n_{\text{eff}}} \quad (1)$$

where n_{eff} is the effective refractive index of the wave guide. Experimentally, one observes that the nonlinear properties of photosensitivity, the limited interference contrast of the inscription laser, and a non-perfect beam stability lead to a decay of the refractive index modulation of the grating during inscription

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[6]–[8]. Therefore, chirped FBGs are required for many broad-band filtering applications, especially with a well-tailored reflection wavelength.

Chirped gratings can be obtained with a chirped phase mask [9] and concatenated phase masks [10]. Chirped gratings have been implemented with a homogeneous phase mask using the phase mask moving technique [11], fiber tilting [12], tapered fiber structures [13]–[15], and stretching or bending the fiber during inscription with phase masks [16], [17]. For all these methods, the reflection wavelength and bandwidth remain closely connected to the choice of the applied phase mask.

Several attempts have been made to apply two beam interferometry to realize chirped gratings due to the great Bragg wavelength versatility of this method. One option is the use of consecutive subgratings made by continuously moving fringe patterns [18]–[22]. Another is the Sagnac interferometer with an integrated phase shifting element [23], [24], where chirp rates of 0.48 nm/cm are achieved. CFBGs with an interferometer setup were also realized through lenses placed inside of the interferometer arms [22], [25] or with the usage of a prism spectrometer [26].

As chirped gratings strongly depend on homogeneous sample exposure, continuous wave lasers are preferred [22]. But the emergence of ultrashort pulse lasers allows refractive index changes to be induced in materials that do not provide conventional photosensitivity [27], [28]. Therefore, adapted inscription methods are proposed which are compatible with ultrashort-pulse laser sources. A direct approach is by the phase mask inscription method with chirped phase masks [29]. Alternative approaches use phase masks with constant pitch and bent fibers [30], tilted wave fronts [31] or a PMMA phase mask together with a thermal gradient [32]. Point-by-point inscription has been demonstrated to be another candidate for CFBG inscription [33].

In this paper we analyze a method in which we integrate a chirped phase mask in an interferometer to realize a continuously chirped phase mask interferometer (C-CPMI) [34]. Two-beam interferometry [35], [36] offers various advantages: it provides wavelength versatility and it works free of contact. It provides a large distance between target fiber and the optical elements and allows high energy density at the fiber position without degradation of the optical components of the interferometer. It is suitable for inscription with ultraviolet and visible femtosecond laser exposure [37], [38]. Additionally, it allows gratings to be written on the fly during the fiber drawing process [39], [40]. The C-CPMI combines all these advantages with CFBG inscription. Additionally, it prevents Talbot diffraction patterns across the waveguide, as can be observed with phase mask inscription [41], [42].

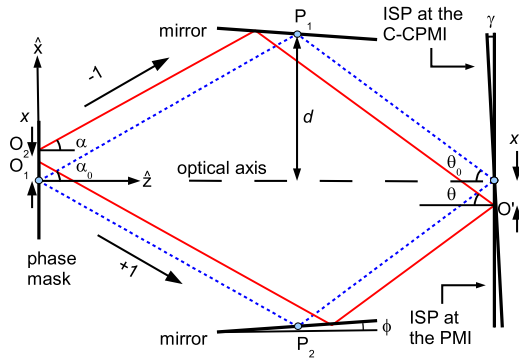


Fig. 1. Chirped PMI setup. At the C-CPMI, the ISP is not perpendicular to the optical axis but tilted at an angle γ . Interfering rays departing from the center of the phase mask (blue dashed line) and from the red side of the phase mask (red solid line) are included.

II. THEORETICAL APPROACH TO THE INTERFEROMETRIC SETUP WITH PHASE MASK

The phase mask interferometer (PMI) (see Fig. 1) splits an incoming ray at the beam-splitting phase mask into two rays with an angle α relative to the optical axis. This angle is defined by the period of the beam-splitting phase mask Λ_{PM} and the inscription wavelength λ_{inscr} . For the first diffraction orders ($m = \pm 1$) it is defined through the relation $\sin(\alpha) = \lambda_{inscr} / \Lambda_{PM}$. These rays are then directed to the fiber position at an angle θ and provide a standing wave pattern along the fiber axis. Assuming that the fiber provides photosensitivity and interacts with the light of the inscription laser, then the interaction of the light with the waveguide results in a grating with center reflection wavelength of

$$\lambda_{Bragg} = n_{eff} \frac{\lambda_{inscr}}{\sin \theta} \quad (2)$$

where $\theta = \alpha + 2\phi$ defines the angle of the rays crossing the fiber in relation to the optical axis, and ϕ is the tilt angle between the mirrors and the xy -plane. The tilt direction of the mirrors is symmetrical to the optical axis. In a non-chirped PMI, the fiber is placed inside the ideal sample plane (ISP). This plane is perpendicular to the optical axis and its distance from the phase mask is defined by

$$z_{ISP} = d (\tan^{-1}(\alpha) + \tan^{-1}(\theta)) \quad (3)$$

where d is the distance between the pivot points (P_1 and P_2) of the mirrors and the optical axis, which is assumed to be the same for both mirrors. The interferometer has two scaling factors: the magnification factor S_M and the wavelength scaling factor S_W . The first one defines the magnification of the PMI [37]:

$$S_M = \frac{x'}{x} = \frac{\cos(\alpha_0)}{\cos(\theta_0)}. \quad (4)$$

Here, x' marks a corresponding position on the sample plane. The wavelength scaling factor S_W defines the relation between the central period of the beam splitter and the resulting Bragg

reflection wavelength:

$$S_W = \frac{\lambda_{Bragg}}{n_{eff} \Lambda_0} = \frac{\sin(\alpha_0)}{\sin(\theta_0)}. \quad (5)$$

A. Calculation of the Chirp

The presented approach for the interferometric inscription setup uses a continuously chirped phase mask as a beam-splitter. The direct consequence is that the diffraction angle $\alpha(x)$ depends on the incoming position x of the rays at the phase mask. This results in an angular distribution of the interfering rays at the fiber position and consequently forms a continuously chirped interference pattern. The linear chirped phase mask is described by the chirp parameter σ which is defined as [43]

$$\frac{1}{\Lambda}(x) = \frac{1}{\Lambda_0} \left(1 + \sigma \frac{x}{L} \right) \quad (6)$$

where L is the length of phase mask, Λ_0 is the center period of the phase mask, and x marks a specific position on the phase mask. The overall chirp range of the whole phase mask is calculated to be approximately $\Delta\Lambda = \sigma\Lambda_0$. Note that $\Lambda_0\sigma/L$ is the chirp rate of the phase mask, usually given in nm/cm. The change of the diffraction angle $\alpha(x)$ with incoming beam position at the phase mask is

$$\sin(\alpha(x)) = \left(1 + \frac{\sigma}{L}x \right) \sin \alpha_0 \quad (7)$$

where α_0 is the reference angle $\sin \alpha_0 = \lambda_{inscr} / \Lambda_0$.

It is important to define the orientation of the ISP for the C-CPMI. This is the plane where all rays departing from the phase mask interfere. It is tilted by an angle γ with respect to the ISP of the standard-PMI. This tilt angle is derived from the variation of interference position (see equation (3)) at different positions x of the split rays at the phase mask:

$$\tan \gamma = \frac{\Delta z_{ISP}}{S_M \Delta x} = \frac{\sigma}{L} \frac{d}{\sin(\alpha) \cos(\alpha) S_M} (1 + S_W^2). \quad (8)$$

The tilt angle γ is zero for the standing wave condition ($\theta = 90^\circ$) and 90° when the ISP is at infinity ($\theta = 0^\circ$). Therefore, the ISPs for the C-CPMI and the PMI get closer for larger beam angles θ . The angle γ becomes zero also if the phase mask has no chirp.

The bandwidth of the chirped grating inscribed in the waveguide is derived from the dependence of the reflection wavelength (see equation (2)) and from the position of the incoming light at the beam-splitting phase mask defined by equation (7):

$$\Delta\lambda_{Bragg} = n_{eff} x_E \frac{\Lambda_0 \sigma}{L} \frac{S_W^2}{S_M}. \quad (9)$$

Here the value x_E is introduced. It defines the effective length of the exposed area at the phase mask. This value is limited by the size of the phase mask $|x_E| \leq L/2$. The spectral reflection bandwidth allows calculation of the dispersion D , taken from reference [44], together with equation (9):

$$D = \frac{2S_M^2}{\Lambda_0 \frac{\sigma}{L} S_W^2 c} \quad (10)$$

where c is the speed of light in vacuum. The phase-mask equivalent chirp rate at the fiber position can be derived from equation

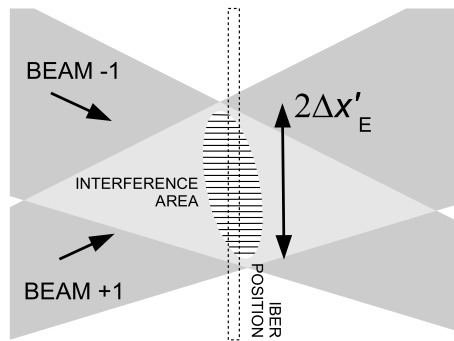


Fig. 2. Diamond-shaped overlap region for the C-CPMI. The interference area is tilted. One beam is slightly convergent and the other divergent. The length of the overlap x'_E is scaled to the effective length of the exposed area at the phase mask with equation (4).

(10) to be

$$\frac{\Delta\Lambda_{\text{equiv}}}{\Delta x'} = \frac{2}{cD} = \frac{\Lambda_0 \sigma S_W^2}{L S_M^2}.$$

B. Influence of the Coherence Properties of the Inscription Laser

The maximum effective length of a chirped fiber Bragg grating and, therefore, the grating reflection bandwidth depend on the size of the diamond-shaped overlap of the interfering beams at the ISP as shown in Fig. 2. This extent of potential interference is reduced due to the temporal and spatial coherence properties of the inscription laser [37].

In our experiments, we placed the fiber perpendicularly to the optical axis at the distance calculated with equation (3). This was done to prevent tilted FBG-fringes and to avoid coupling of guided light from the core into the cladding [45]. The focal length of the phase mask $f = \pm \sigma \tan(\alpha)/L$ (see Fig. 2) also defines the tilt angle of the interference fringes according to the standing wave condition. For the applied phase mask f is approximately 9 m. Therefore we expect that the induced tilt angles of the fringes itself are very small compared to the tilt of the interference pattern.

In the case where the fiber has no tilt angle, two rays interfering at the fiber originate from different positions on the phase mask (O_1 and O_2), except on the optical axis ($x = 0$), where these points coincide. The corresponding distance l_x of interfering rays departing from positions on the phase mask is defined by

$$l_x = \overline{O_1 O_2} = 2 \times \Delta z_{\text{ISP}} \frac{\sin \theta}{\cos \alpha} = 2x \tan \gamma \tan \theta \quad (11)$$

where x is the distance in the phase mask position from the optical axis. It is at the center between the two points O_1 and O_2 . When the value for l_x exceeds the spatial coherence length of the laser, the interference in the inscription plane ceases to exist. This is a direct consequence of the tilt of the interference at the ISP and is relevant for lasers with limited spatial coherence length.

TABLE I
LASERS USED FOR TESTING THE C-CPMI

| Type | Excimer laser | Femtosecond laser |
|-----------------|--------------------|--------------------|
| Wavelength | 248 nm | 267 nm |
| Pulse length | 20 ns | 400 fs |
| Pulse energy | 150 mJ | 0.3 mJ |
| Rep. rate | 10 Hz | 1000 Hz |
| Spat. coherence | 450 μm | several millimeter |
| Temp. coherence | several millimeter | 120 μm |

The parameters given are experimentally applied values for FBG inscription.

For lasers with a short temporal coherence length, the maximum length l_t of a grating is given by [37]

$$l_t = \left| \frac{l_c^t \cos(\alpha)}{\sin(2\phi)} \right| \quad (12)$$

where l_c^t is the temporal coherence length of the inscription laser. For small mirror tilt angles, this value is limited by the effective length of the exposed area on the phase mask. For $l_t < x_E$ the spectral width is then limited by l_t according to equation (9) with the scaling factors (S_M and S_W) of unity: $\Delta\lambda_{\text{Bragg}} = n_{\text{eff}} \sigma \Lambda l_t / L$.

III. EXPERIMENTAL DETAILS

Inscription experiments with the C-CPMI are done with a phase mask fabricated in-house (IPHT) with a central pitch of 706.5 nm and a chirp rate of 2.3 nm/cm. The phase mask was manufactured using electron beam lithography [46].

For inscription experiments, two laser systems were used. Both systems provide high output power and high photon energy (deep ultraviolet, DUV), but with different coherence properties. One laser is the Mantis-Legend Elite-Tripler femtosecond laser from Coherent Inc. The other laser tested is a Compex 150 T KrF excimer laser from Lambda Physics, now Coherent. The operating parameters of the lasers used for experiments are listed in Table I.

A. Experimental Measurement of the Tilt Angle

To confirm the predicted values for the tilt angle γ as described by equation (8), we exposed the phase mask pointwise with a pin hole at two well-defined different positions at the x -axis. We then measured the resulting change of the overlap position of the rays using a high-precision translation stage to move a screen along the optical (z -)axis around the distance from the phase-mask according to equation (3) to find the intersection of the beams at the fiber position. This experiment was done for two mirror tilt positions and in comparison with a different phase mask (708.6 nm central period and 6.1 nm/cm chirp rate from Ibsen Photonics). The results are given in Fig. 3 and are compared with the expected values from equation (8). As predicted, the tilt angle γ increases with increasing chirp. It also increases with decreasing tilt angle of the mirrors and therefore with increasing Bragg reflection wavelength.

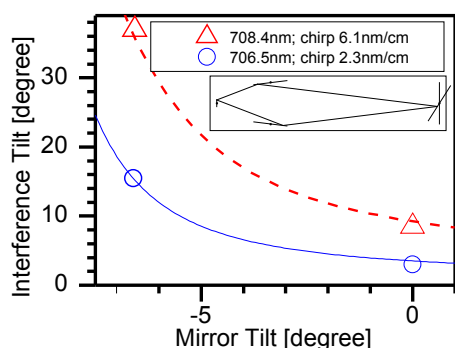


Fig. 3. Experimentally determined ISP tilt angles (circle, triangle) compared to theoretical prediction from equation (8) (lines). The inset shows the geometry of Fig. 1 and a tilt angle of $\phi = -7^\circ$.

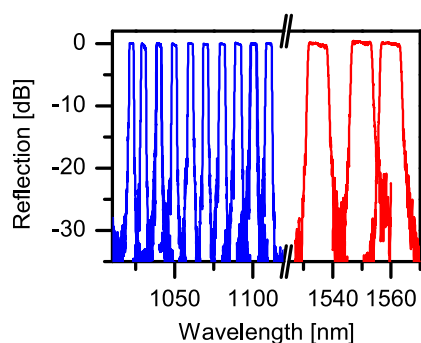


Fig. 4. Sample spectra of ten chirped gratings in the ytterbium amplification band and three chirped gratings in the erbium amplification band.

B. Inscription with Excimer Laser

1) *Chirped Multi-Pulse Gratings*: We performed grating inscription experiments with the aforementioned phase mask from IPHT and an entrance slit of 1 cm to investigate the influence of the spatial coherence properties of the excimer laser. With this phase mask it was possible to inscribe chirped gratings from the visible spectral region (660 nm) up to the infrared (2000 nm). All gratings are inscribed in hydrogen-loaded commercial single-mode fibers (HP630, and 1060XP from Thorlabs Inc.) [47], [48]. For the gratings that reflect in the short-wave infrared region (Er-Tm-band) we used a standard single-mode fiber following ITU-T G.652.

Sample spectra of grating arrays in the ytterbium and erbium amplification band are shown in Fig. 4. The reflection bandwidths of the resulting single grating increase with increasing wavelength from 3 nm at 1030 nm reflection bandwidth to 7 nm at 1550 nm. This behavior complies with observations in the literature, where longer reflection wavelengths come with broader reflection bandwidths [34]. The reflection bandwidth versus Bragg reflection wavelength is shown in Fig. 5. The estimated bandwidth using equation (9) (solid line) is also included. The dashed line in the same figure takes into account that the effective grating length is influenced by the spatial coherence length of the laser according to equation (11). Besides the bandwidth, we also measured the group delay of the grating at 1535 nm

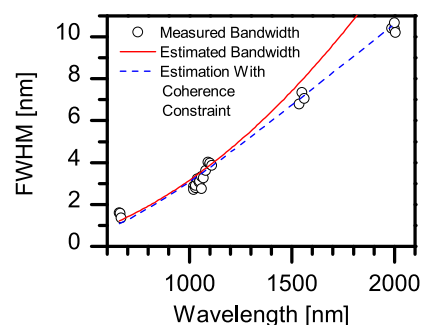


Fig. 5. Reflection bandwidth of the chirped gratings inscribed with excimer laser from the visible to the infrared. It increases with the target wavelength. At reflection wavelengths in the infrared, influence of the spatial coherence length becomes observable.

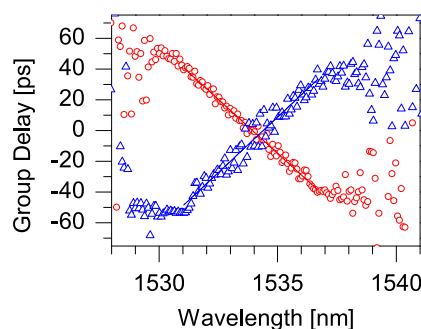


Fig. 6. Measured group delay of a chirped grating in both directions. Triangles are measured from blue to red, and circles *vice versa*.

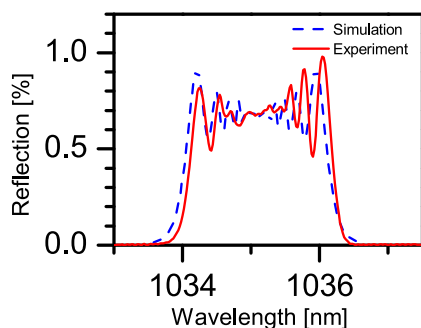


Fig. 7. Reflection spectrum of a single-pulse C-CFBG in a photosensitive fiber in comparison to theory.

wavelength (see Fig. 4) using an optical network analyzer (Advantest Q7750 Optscope). The slope of the curves is shown in Fig. 6 and gives an experimental dispersion value of 14.2 ps/nm, which is close to the theoretically predicted value of 12.0 ps/nm according to equation (10).

2) *Chirped Single-Pulse Gratings*: Single-pulse fiber Bragg gratings are of great interest for situations where multiple pulses cannot be used for inscription. This applies especially for gratings written on the fly during the fiber drawing process [39], [40]. Fig. 7 shows the reflection spectrum of a grating written with a single pulse and a slit width of 7 mm. The fiber used is a single-mode photosensitive fiber with a highly germanium-doped core with about 18 mol% GeO₂. For comparison, the same figure

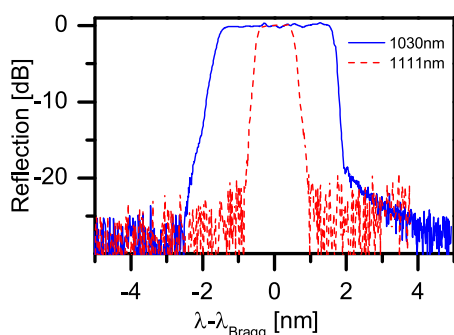


Fig. 8. Comparison of grating spectra made with femtosecond DUV radiation and different tilt angles of the mirrors. The reflection wavelengths are 1030 and 1111 nm respectively.

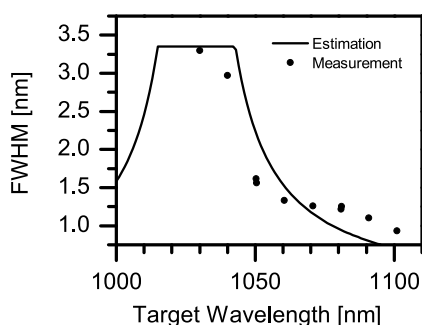


Fig. 9. Spectral width versus wavelength for FBG inscription with C-CPMI and DUV femtosecond laser. The solid line is an estimation for the spectral width to be achieved with the applied femtosecond laser. The dots are experimental values for the 3 dB reflection bandwidth.

includes the theoretical spectrum for a grating with 7 mm length and a refractive index modulation of $\Delta n = 2.6 \times 10^{-5}$, which was fitted with a transfer-matrix formalism [15], [49]. It shows a good agreement with the measured spectrum.

C. C-CFBG Array Inscription with DUV Femtosecond-Laser-Driven Interferometer

Fiber Bragg gratings are written with different reflection wavelengths in a single-mode fiber (1060XP) without hydrogen loading to test the influence of the pulse length of a short-pulse laser source. For each grating, the spectral width (FWHM) is recorded versus the reflection wavelength. As predicted by equation (12), the selection of a specific wavelength by tilting the mirrors affects the effective grating length and therefore the spectral width of the grating. Fig. 8 shows the reflection of two gratings. One grating reflects at the design wavelength of the phase mask (1030 nm) and has a reflection bandwidth of 3.3 nm, which reduces down to 1 nm for the other grating that reflects at 1111 nm. To show that such a reduction is caused by the effect of the grating length reducing with increasing mirror tilt $|\phi|$, we estimated the maximum bandwidth versus target wavelength using equation (12). This is represented by the solid line in Fig. 9. The flat region around 1030 nm is defined by the entrance slit of 1 cm, which corresponds to a maximum reflection bandwidth of 3.35 nm. Fiber Bragg gratings have been successfully inscribed for a wavelength range from 1030 to 1100 nm. The result in

Fig. 9 shows that it is possible to inscribe chirped gratings over a wide spectral range with the same beam-splitting phase mask and a femtosecond laser source. The maximum spectral reflection bandwidth of the gratings is obtained in close proximity to the design Bragg reflection wavelength of the phase mask. We did not observe a reduction of the contrast in the interference pattern due to the spectral width of the applied laser. It is possible to expand the wavelength range of the PMI by further adjusting the geometry of the phase mask and the beam splitter [50].

IV. CONCLUSION

The chirped PMI has been shown to be suitable for the inscription of chirped fiber Bragg gratings with good wavelength versatility. Best results can be obtained when coherence properties of the applied laser system are taken into account. In this study, two laser systems with opposing coherence properties were investigated: an ultraviolet excimer and an ultraviolet femtosecond laser. With the excimer laser source, gratings were written from the visible spectral range up to the short-wave infrared range at 2000 nm. The bandwidth of the gratings increases with increasing Bragg reflection wavelength and reached values up to 10 nm. Chirped fiber Bragg gratings written with a single pulse demonstrate the potential for grating inscription even during the fiber drawing process. Wavelength versatility was also shown with the DUV femtosecond laser with a reduced wavelength range compared to the excimer laser source. This is related to the pulse length of the inscription laser. We believe that inscription with the chirped PMI with femtosecond laser and excimer laser opens novel applications, such as resonator mirrors for fiber laser setups and special filters for biophotonic applications.

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